

## N-Channel 60 V (D-S) MOSFET

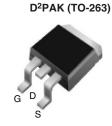
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Max)			
60	0.023 at V <sub>GS</sub> = 10 V	50	66 nC			
00	0.027 at V <sub>GS</sub> = 4.5 V	40	00110			

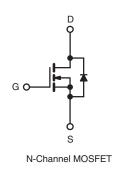
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC









<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)									
PARAMETER	SYMBOL	LIMIT	UNIT						
Drain-Source Voltage			V <sub>DS</sub>	60	V				
Gate-Source Voltage	V <sub>GS</sub>	± 10	v						
Continuous Drain Current <sup>f</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	50					
Continuous Drain Current	VGS at 10 V	T <sub>C</sub> = 100 °C		36	A				
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200					
Linear Derating Factor				1.0	W/°C				
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.025	VV/ C				
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ				
Maximum Power Dissipation $T_{\rm C} = 25 ^{\circ}{\rm C}$		25 °C	Р	150	w				
Maximum Power Dissipation (PCB Mount)e		25 °C	P <sub>D</sub>	3.7					
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns				
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C				
Soldering Recommendations (Peak Temperature) <sup>d</sup> for 10 s				300 <sup>d</sup>					

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ ,  $L = 179 \text{ }\mu\text{H}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = 51 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 51 \text{ A}$ , dl/dt  $\le 250 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

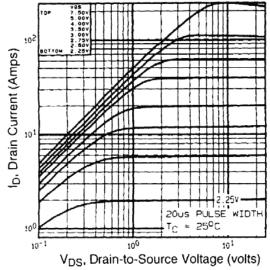
d. 1.6 mm from case.



THERMAL RESISTANCE RATI	NGS	-						
PARAMETER	SYMBOL	DL TYP. MAX		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 62			°C/W			
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	- 40						
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 1.0						
ote When mounted on 1" square PCB (FR-4 o	or G-10 material	).						
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C, u	nless otherw	rise noted)						
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNI
Static		•				-		•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 25	0 μΑ	60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		1.0	-	3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 10 \text{ V}$		-	-	± 100	nA	
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		= 0 V	-	-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$		-	-	250	μA	
Drain-Source On-State Resistance		V <sub>GS</sub> = 10 V	I <sub>D</sub>		-	23	-	Ω
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V	I <sub>D</sub>	= 15 A <sup>b</sup>	-	27	-	
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 25 \text{ V}, \text{ I}_{D} = 21 \text{ A}^{\text{b}}$		23	-	-	S	
Dynamic	010				1		1	
Input Capacitance	C <sub>iss</sub>					3000	-	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5			-	1000	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	200	-		
Total Gate Charge	Qg				-	60	-	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5.0 V		A, $V_{DS} = 48 V$ ,	-	10	-	
Gate-Drain Charge	Q <sub>gd</sub>		see tiç	g. 6 and 13 <sup>b</sup>	-	40	-	
Turn-On Delay Time	t <sub>d(on)</sub>			-	17	-	+	
Rise Time	t <sub>r</sub>		= 30 V, I <sub>D</sub> =	51 A	_	230	_	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			, see fig. 10 <sup>b</sup>	-	42	_	
Fall Time	t <sub>f</sub>				_	110	_	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50°	A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	200		
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25 \text{ °C}, I_S = 51 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{\rm J} = 25 ^{\circ}\text{C}, I_{\rm F} = 51 \text{A}, \text{dl/dt} = 100 \text{A/}\mu\text{s}^{\rm b}$		-	130	180	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time i	s negligible (turn	-on is dor	ninated b	vlaand	1-2)

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



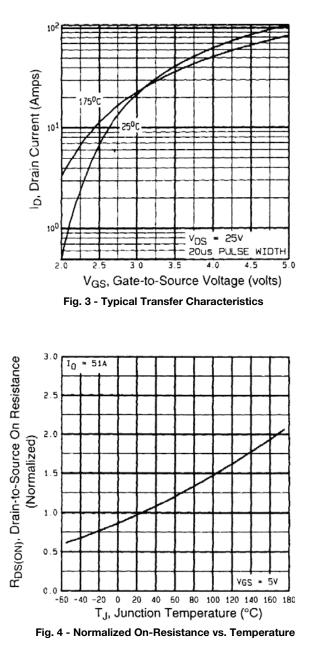


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C





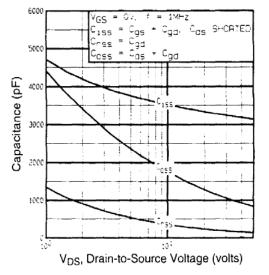


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

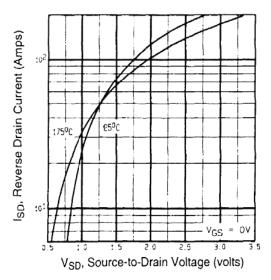


Fig. 7 - Typical Source-Drain Diode Forward Voltage

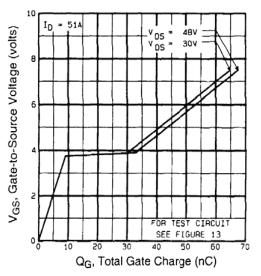
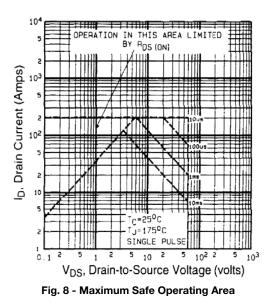


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





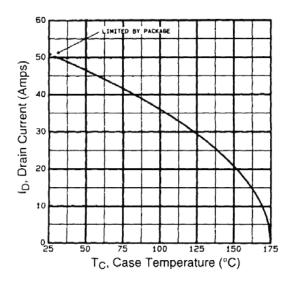


Fig. 9 - Maximum Drain Current vs. Case Temperature

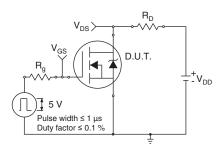


Fig. 10a - Switching Time Test Circuit

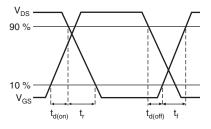


Fig. 10b - Switching Time Waveforms

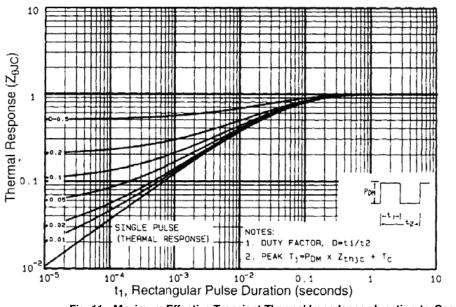


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



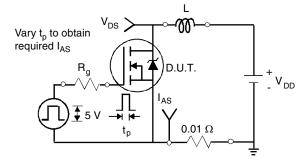


Fig. 12a - Unclamped Inductive Test Circuit

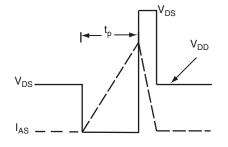


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

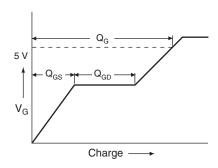


Fig. 13a - Basic Gate Charge Waveform

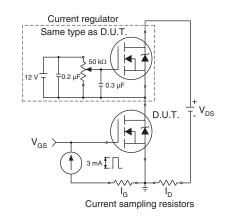
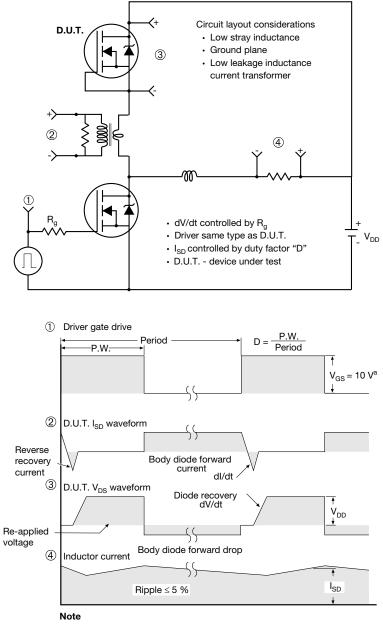


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

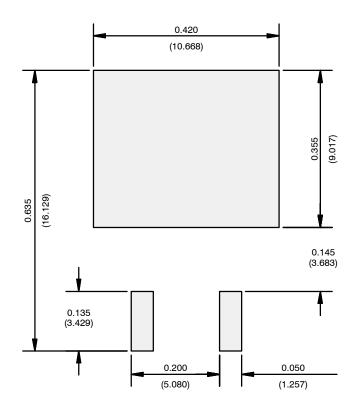


a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



### **RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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